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	Application No.	Applicant(s)
Notice of Allowability	10/633,414	CHEN ET AL.
	Examiner	Art Unit
	Rose M. Miller	2856
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308. 1. This communication is responsive to amendment filed 28 February 2005. 2. The allowed claim(s) is/are 1-7 and 9-20. 3. The drawings filed on 04 August 2003 are accepted by the Examiner. 4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some* c) None of the: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)). * Certified copies not received: Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.		
 THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient. CORRECTED DRAWINGS (as "replacement sheets") must be submitted. (a) including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached (b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date 		
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d). 7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/0: Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Sumr Paper No./Ma 8), 7. ☐ Examiner's Am	il Date

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REASONS FOR ALLOWANCE

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1. The following is an examiner's statement of reasons for allowance: The prior art of record fails to teach and/or suggest a system or method for detecting flaws in a wafer, specifically a semiconductor wafer, which includes a cross-bar ultrasonic detection device, i.e. an ultrasonic transducer, with a width which is either wider than or equal to a radius of the wafer under test or which utilizes a plane wave to test the wafer.

The closest prior art is that of Takisha et al. which teaches utilizing a scanning mechanism to scan the ultrasonic device (ultrasonic transducer) over the whole object under test. This allows for any type of transducer, particularly a spot focused transducer, to test the object and to insure that the whole object is tested. The prior art fails to teach a single ultrasonic device (transducer) which is of a size equal to the radius of the wafer or object under test as such a large transducer can be difficult to obtain and the results obtained by the large transducer can be difficult to read when a specific defect, or a specific location within the test object, is being tested.

The closest prior art also fails to teach the use of an ultrasonic plane wave for interrogating the wafer under test. The use of the plane wave effectively shortens the detecting time by interrogating more of the wafer in a single pulse and allowing for a quicker testing. This is especially true when the plane wave encompasses the whole diameter of the wafer under test as disclosed in the embodiments found in the specification and drawings of Applicant's invention.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Rose M. Miller whose telephone number is 571-272-2199. The examiner can normally be reached on Monday - Friday, 7:30 am to 3:30 pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Hezron Williams can be reached on 571-272-2208. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

RMM

7 May 2005

HEZRON WILLIAMS

SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800